

FDA18N50 N-Channel UniFETTM MOSFET 500 V, 19 A, 265 mΩ

Features

- $R_{DS(on)} = 265 \text{ m}\Omega \text{ (Max.)} \otimes V_{GS} = 10 \text{ V, ID} = 9.5 \text{ A}$
- Low Gate Charge (Typ. 45 nC)
- Low C_{rss} (Typ. 25 pF)
- 100% Avalanche Tested

Applications

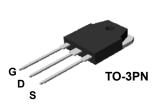
- PDP TV
- Uninterruptible Power Supply
- AC-DC Power Supply

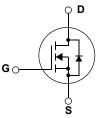
April 2013

FDA18N50 N-Channel UniFETTM MOSFET

Description

UniFETTM MOSFET is Fairchild Semiconductor[®], s high voltage MOSFET family based on planar stripe and DMOS technology. This MOSFET is tailored to reduce on-state resistance, and to provide better switching performance and higher avalanche energy strength. This device family is suitable for switching power converter applications such as power factor correction (PFC), flat panel display (FPD) TV power, ATX and electronic lamp ballasts.





Absolute Maximum Ratings

Symbol	Parameter			FDA18N50	Unit	
V _{DSS}	Drain-Source Voltage		e 500		V	
I _D	Drain Current	- Continuous (T _C = 25°C) - Continuous (T _C = 100°C		19 11.4	A A	
I _{DM}	Drain Current	- Pulsed (Note 1)		76	А	
V _{GSS}	Gate-Source voltage			±30	V	
E _{AS}	Single Pulsed Avalanche Energy		(Note 2)	945	mJ	
I _{AR}	Avalanche Current		Avalanche Current (Note 1)		19	А
E _{AR}	Repetitive Avalanche Energy		(Note 1)	23	mJ	
dv/dt	Peak Diode Recovery dv/dt		(Note 3)	4.5	V/ns	
P _D	Power Dissipation	(T _C = 25°C) - Derate above 25°C		239 1.92	W W/°C	
T _{J,} T _{STG}	Operating and Storage Temperature Range			-55 to +150	٥C	
TL	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds			300	°C	

Thermal Characteristics

Symbol	Parameter	FDA18N50	Unit	
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case, Max.	0.52	°C/W	
R_{\thetaJA}	Thermal Resistance, Junction-to-Ambient, Max.	40	-0/W	

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•		Device	Pac	Package Reel Size Tap		e Width		Quantity		
		TO-	-3PN -		-		30			
Electric	al Char	racteristics T _c	= 25°C unles	s otherwise note	ed					
Symbol		Parameter			Conditions		Min.	Тур.	Мах	Unit
Off Charac	teristics									I
BV _{DSS}	Drain-Source Breakdown Voltage		ge	V _{GS} = 0V, I _D = 250μA		500			V	
ΔBV _{DSS} / ΔT _J			re	$I_D = 250 \mu A$, Referenced to $25^{\circ}C$			0.5		V/°C	
I _{DSS}	Zero Gate Voltage Drain Current		nt	V_{DS} = 500V, V_{GS} = 0V V_{DS} = 400V, T_{C} = 125°C					1 10	μΑ μΑ
I _{GSSF}	Gate-Bod	Gate-Body Leakage Current, Forward		$V_{GS} = 30V, V_{DS} = 0V$					100	nA
I _{GSSR}	Gate-Bod	Body Leakage Current, Reverse		$V_{GS} = -30V, V_{DS} = 0V$				-100	nA	
On Charac	teristics					ľ				
V _{GS(th)}	Gate Thre	hreshold Voltage		$V_{DS} = V_{GS}$	$V_{DS} = V_{GS}, I_D = 250 \mu A$		3.0		5.0	V
R _{DS(on)}	Static Drain-Source On-Resistance			V _{GS} = 10V, I _D = 9.5A			0.220	0.265	Ω	
9 _{FS}	Forward Transconductance			V _{DS} = 40V,	I _D = 9.5A			25		S
Dynamic C	haracteris	tics								
C _{iss}	Input Cap	Input Capacitance Output Capacitance		V _{DS} = 25V, V _{GS} = 0V, f = 1.0MHz			2200	2860	pF	
C _{oss}	Output Ca						330	430	pF	
C _{rss}	Reverse Transfer Capacitance						25	40	pF	
Switching	Characteri	stics								
t _{d(on)}	Turn-On Delay Time			V _{DD} = 250V, I _D = 19A			55	120	ns	
t _r	Turn-On F	Rise Time		R _G = 25Ω (Note 4)				165	340	ns
t _{d(off)}	Turn-Off	Delay Time					95	200	ns	
t _f	Turn-Off F	all Time					90	190	ns	
Qg	Total Gate	e Charge		V _{DS} = 400V, I _D = 19A			45	60	nC	
Q _{gs}	Gate-Sou	urce Charge		V _{GS} = 10V				12.5		nC
Q _{gd}	Gate-Drai	n Charge		(Note 4		(Note 4)		19		nC
	rce Diode C	Characteristics and I	Maximum	Ratings				I	1	I
I _S	Maximum	Continuous Drain-So	ource Diod	e Forward C	Current				19	Α
I _{SM}	Maximum Pulsed Drain-Source Diode F		Diode Fo	orward Current				76	Α	
V _{SD}	Drain-Sou	Irce Diode Forward V	oltage	V _{GS} = 0V, I	_S = 19A				1.4	V
t _{rr}	Reverse F	Recovery Time		V _{GS} = 0V, I				500		ns
Q _{rr}	Reverse F	Recovery Charge		$\frac{V_{GS} = 00, 1S}{dI_F/dt} = 100A/\mu s$			5.4		μC	

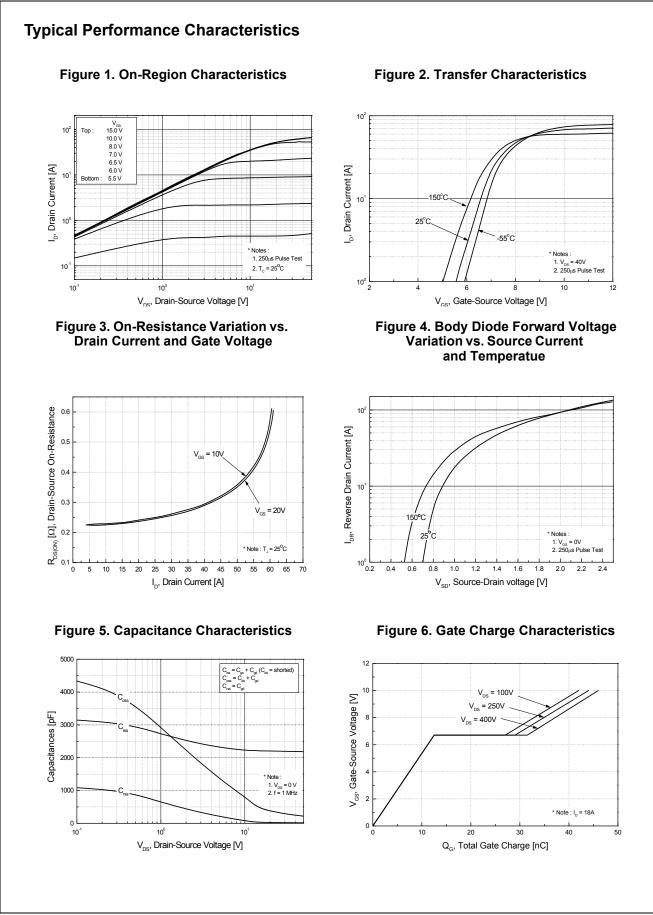
NOTES:

1. Repetitive Rating: Pulse width limited by maximum junction temperature

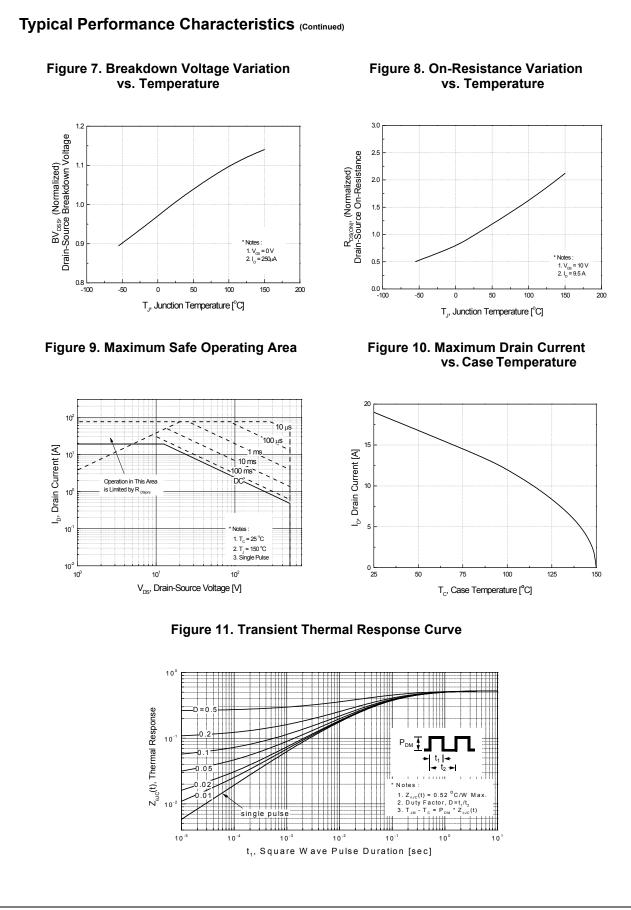
2. L = 4.7mH, I_{AS} = 19A, V_DD = 50V, R_G = 25 Ω , Starting T_J = 25°C

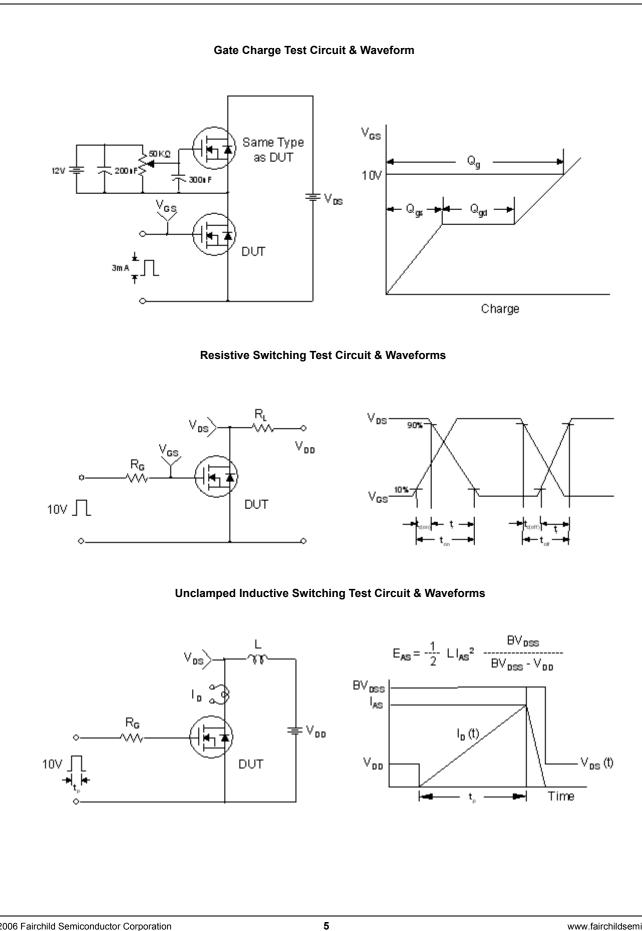
3. $I_{SD} \leq$ 19A, di/dt \leq 200A/µs, $V_{DD} \leq BV_{DSS},$ Starting T_J = 25°C

4. Essentially Independent of Operating Temperature Typical Characteristics

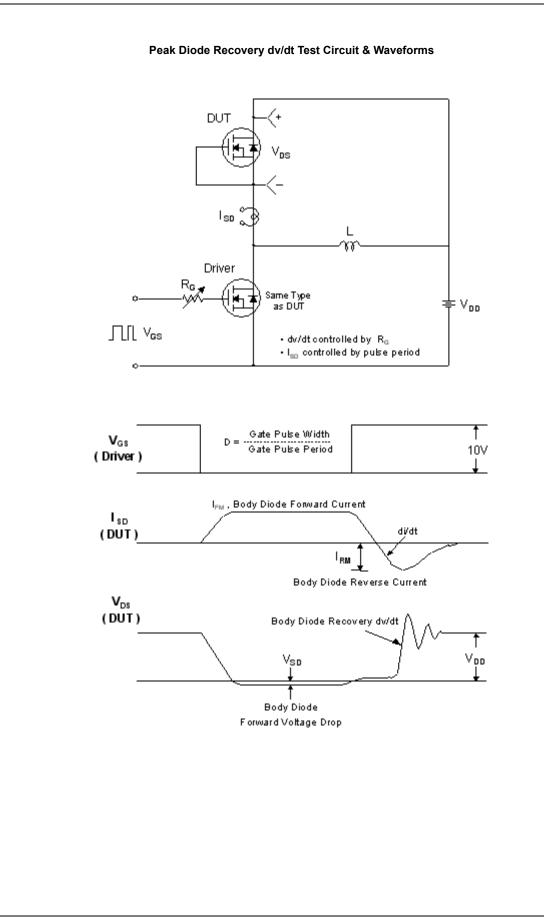


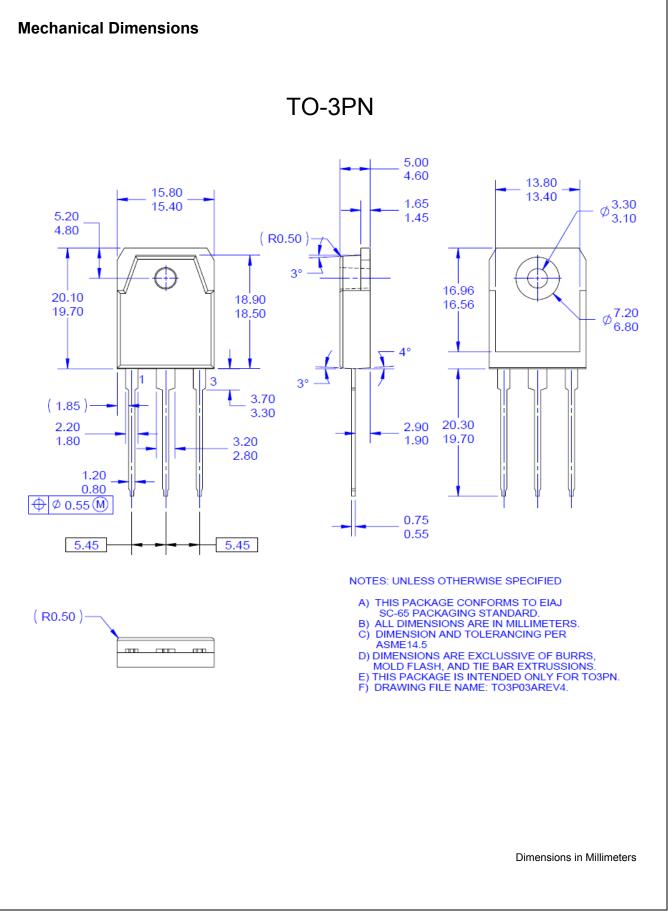
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